ADVANCED

MATHEMATICAL & COMPUTATIONAL TOOLS IN METROLOGY & TESTING VIII

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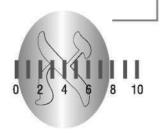
Universitede la Mediterranee, France

C Perruchet

UTAC, Montlhery, Prance

N F Zhang

N1ST. USA





Published by

World Scientific Publishing Co. Pte. Ltd.

5 Toh Tuck Link, Singapore 596224

USA office: 27 Warren Street, Suite 401-402, Hackensack, NJ 07601 UK office: 57 Shelton Street, Covent Garden, London WC2H 9HE

Library of Congress Cataloging-in-Publication Data

AMCTM VIII (2008: Paris, France)

Advanced mathematical and computational tools in metrology and testing : AMCTM VIII / edited by Franco Pavese ... [et al.].

p. cm. -- (Series on advances in mathematics for applied sciences; v. 78)

Includes index.

ISBN-13: 978-981-283-951-0 (hardcover : alk. paper)

ISBN-10: 981-283-951-8 (hardcover : alk. paper)

- 1. Measurement--Congresses. 2. Physical measurements--Congresses. 3. Metrology--Congresses.
- I. Pavese, Franco. II. Title. III. Title: AMCTM 8.

QA465.A58 2008

530.8--dc22

2009001775

British Library Cataloguing-in-Publication Data

A catalogue record for this book is available from the British Library.

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Printed in Singapore.

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